



PATENT  
DOCKET NO.: 29284/548

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Inventors : Mitsuo TOKUDA, et al.  
Serial No. : 09/960,479  
Filed : September 24, 2001  
Patent No. : 6,781,125 B2 Issued August 24, 2004  
For : METHOD AND APPARATUS FOR PROCESSING A MICRO  
SAMPLE

Mail Stop **CERTIFICATE OF CORRECTION BRANCH**  
COMMISSIONER FOR PATENTS  
P.O. Box 1450  
Alexandria, Virginia 22313-1450

**Certificate**  
**JUL 29 2005**  
**of Correction**

**REQUEST FOR CERTIFICATE OF CORRECTION**  
**PURSUANT TO 37 C.F.R. §§ 1.322 & 1.323**

SIR:

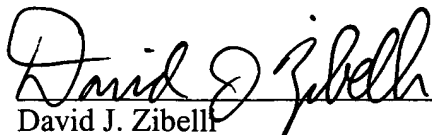
We are returning the original Certificate of Correction and respectfully request issuance of the enclosed new Certificate since the first correction was omitted by the Office and other corrections list the incorrect column and line numbers. The corrections are marked on the enclosed copy of the original Certificate of Correction.

Applicants hereby request that the enclosed Certificate of Correction be issued for the above Patent under authority of 35 USC §§ 254 and 255.

Please charge Deposit Account No. 11-0600 in the amount of \$100.00 to cover the fee under 37 CFR § 1.20(a). A copy of this sheet is enclosed for this purpose.

Respectfully submitted,

Dated: July 22, 2005

  
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07/25/2005 ZJUHR1 00000102 110600 6781125  
01 FC:1811 100.00 DA

AUG 03 2005

UNITED STATES PATENT AND TRADEMARK OFFICE

**CERTIFICATE OF CORRECTION**

**PATENT NO.** : 6,781,125 B2 Page 1 of 1  
**DATED** : 24 August 2004  
**INVENTOR(S)** : Mitsuo TOKUDA, et al.

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

**In the Title Page** under “(30) Foreign Application Priority Data”, third line:

delete “Feb. 23, 2001 (JP) 2001-049303.”

<b><u>Column</u></b>	<b><u>Line</u></b>	
2	11	Change “which falls a technical limit” to --which falls below a technical limit--.
6	34	Change “apples” to --applies--.
19	47	Change “miniaturize” to --miniaturized--.
23	56-57	Change “FIG. 27 is a sectional view when a probe moving mechanism 201 of the present invention is figure, an ” to - -FIG. 27 is a sectional view of a probe moving mechanism 201 of the present invention. In this figure, an--.
24	16	Delete “is considered to be connected to the circuit in design”.
25	10	Change “election beam” to --electron beam--.
25	33	Change “election beam” to --electron beam--.

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Patent No.: 6,781,125 B2

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UNITED STATES PATENT AND TRADEMARK OFFICE  
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PATENT NO. : 6,781,125 B2  
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Page 1 of 1

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*In the title Page under "(30) Foreign Application Priority Data,"  
Third line: delete "Feb 23, 2001 (JP) ... 2001-049303."*

Column 2,

Line 11, change "which falls a technical limit" to -- which falls below a technical limit --.

Column 6,

Line 34, change "apples" to -- applies --.

<sup>23</sup>  
Column 14, 56-57

Line 46, change "FIG. 27 is a sectional view when a probe moving mechanism 201 of the present invention is figure, an" to -- FIG. 27 is a sectional view of a probe moving mechanism 201 of the present invention. In this figure, an --.

<sup>19</sup>  
Column 23, (14)

Lines ~~56-57~~, change "miniaturize" to -- miniaturized --.

Column 24,

Line 16, delete "is considered to be connected to the circuit in design".

Column 25,

Lines 10 and 33, change "election beam" to -- electron beam --.



Signed and Sealed this

Twelfth Day of July, 2005

JON W. DUDAS

Director of the United States Patent and Trademark Office

UNITED STATES PATENT AND TRADEMARK OFFICE  
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Column 2.

Line 11, change "which falls a technical limit" to -- which falls below a technical limit --.

Column 6.

Line 34, change "apples" to -- applies --.

Column 14.

Line 16, change "FIG. 27 is a sectional view when a probe moving mechanism 201 of the present invention is figure, an" to -- FIG. 27 is a sectional view of a probe moving mechanism 201 of the present invention. In this figure, an --.

Column 23.

Lines 56-57, change "miniaturize" to -- miniaturized --.

Column 24.

Line 16, delete "is considered to be connected to the circuit in design".

Column 25.

Lines 10 and 33, change "election beam" to -- electron beam --.



Signed and Sealed this

Twelfth Day of July, 2005

A handwritten signature in black ink, appearing to read "Jon W. Dudas".

JON W. DUDAS  
*Director of the United States Patent and Trademark Office*